



Datasheet Source Measure Unit

Stock No.: Model: 260-2861 RSSM-20H10





FEATURES

- Maximum Output ±210V/±1.05A/22W
- Built-in 4 Sequence Output Modes (Stair, Log, SRC-MEM, Custom), up to 2500 Points
- OVP /OTP Protection Function
- 0.012% Basic Measure Accuracy with 6½-digit Resolution
- Variable Sampling Speed
- SDM (Source Delay Measure) Cycle
- 2-, 4-, and 6-wire Remote V-source and Measure Sensing
- Variable Display Digits
- Built-in Limit Function
- Built-in 5 Calculation Functions
- 4.3" TFT LCD, Digital Number Keyboard
- Built-in RTC Clock
- Interface: RS-232, USBTMC, LAN, GPIB (Optional)





Streamline Your Characteristic Analysis

RSSM-20H10 is a Source Measure Unit that provides highly stable DC power and instrument-grade 6½-digit multimeter measurements. While operating, it can be used as a voltage source, current source, voltmeter, ammeter, and ohmmeter, which is uniquely ideal for the evaluation of component characteristics and the test applications of production, including nanomaterials and components, semiconductor architecture, organic materials, high-efficiency illumination, passive components and material characteristics analysis, etc.

RSSM-20H10 provides four-quadrant operation of $\pm 210V/\pm 1.05A/22W$. The first and third quadrants operate as power supplies to supply power to the load. The second and fourth quadrants function as loads to consume power internally. Voltage value, current value and resistance value can be measured while operating the power supply or load function with an accuracy of 0.012% and a resolution of $1\mu V/10pA/10\mu\Omega$.

With respect to sampling rate, RSSM-20H10 supports a sampling rate of up to 50k points/second, which can accurately analyze the characteristics of the DUT. With the large 4.3-inch screen, all measurement settings, parameters and results can be completely displayed on the screen. The SDM (Source Delay Measure) function is provided to delay sampling when the signal changes so as to prevent the unstable signal from being captured and cause misjudgment. There are four built-in sequence output modes (Stair, Log, SRC-MEM, Custom), which can support up to 2500 points of sequence variation output.

Pertaining to protection, RSSM-20H10 provides OVP/OTP modes. The design of OVP allows users to self-define the range of OVP. OTP can effectively prevent errors caused by temperature drift during the test process. For interfaces, this product supports standard SCPI commands and provides RS-232, USBTMC, LAN, GPIB (optional) interfaces to meet users' different interface needs.

SPECIF	ICATIONS	5											
	Voltage		±210V										
MAXIMUM RANGE	Current		±1.05A										
	Power		22W										
	Voltage Resolution		1μV										
	Current Resolution		10pA										
		Output Voltage	±21V / ±1.05A, ±210V / ±105 mA										
SOURCE		Current Limit	Min. 0.1% of range										
		Programming Resolution &	Range ±200.000mV		mV	±2.00000V		±20.0000V	±	±200.000V			
		Accuracy *1	Resolution	Resolution 1µV		10μV		100μV		1mV			
			Accuracy	Accuracy ±(0.02%+600μV)		±(0.02%+600µV)		±(0.02%+2.4mV)	±(0.	02%+24mV)			
	DC Voltage	Load Regulation	0.01% of range + 100μV										
	DC Voltage	Line Regulation	0.01% of range										
		Overshoot	<0.1% typical (full scale step,resistive load, 10mA range)										
		Recovery Time (1000% Load Change)	<2250µs (within 0.1% plus load regulation errors, 1A and 100mA compliance)										
		Ripple and Noise	4mVrms(20Hz~1MHz) / 10mVpp(20Hz~1MHz)										
		Temperature Coefficient	±(0.15 × accuracy specification)/°C (0°-18°C & 28°-50°C)										
		Output Current	±1.05A / ±21V, ±105 mA / ±210V										
		Voltage Limit	Min. 0.1% of range										
		Programmed Source Resolution & Accuracy *1	Range	±1.00000μA	±10.0000µA	±100.000µA	±1.00000mA	±10.00000mA	±100.000mA	±1.00000A			
	DC Current		Resolution	10pA	100pA	1nA	10nA	100nA	1μΑ	10μΑ			
			Accuracy	±(0.035%+600pA)	±(0.033%+2nA)	±(0.031%+20nA)	±(0.034%+200nA)	±(0.045%+2μA)	±(0.066%+20µA)	±(0.27%+900µA)			
		Load Regulation	0.01% of range + 100pA										
		Line Regulation	0.01% of range										
		Overshoot	<0.1% typical (1mA step, RL = 10kΩ, 20V range)										
		Temperature Coefficient	±(0.15 × accuracy specification)/°C (0°-18°C & 28°-50°C)										
		Output Settling Time *2	100µs typical time										
		Output Rise Time (±30%)	300µs, 200V range, 100mA compliance ; 150µs, 20V range, 100mA compliance										
		DC Floating Voltage		ated up to ±250VDC									
	General	Remote Sense	Up to 1V drop per										
		Compliance Accuracy		\pm and \pm 0.02% of reading to									
		Range Change Overshoot *3		Adjacent range changes between 200mV, 2V and 20V ranges, 100mV typical									
		Minimum Compliance Value	0.1% of range										
		Command Processing Time *4	Autorange On:10r	ns. Autorange Off: 7ms									





SDECIEV	CATIONS													
SPECIFIC	CATIONS													
		Input Resistance	>10 GΩ											
MEASUREMENT		Measurement Resolution &	Range	±200.0			±2.00000V			±20.0000V			±200.000V	
	Voltage	Accuracy	Resolution	1μ		-	10μV			100µV			1mV	
			Accuracy	±(0.012%		±(0	.012%+300μV)			±(0.015%+1.5m)	V)	±(0	0.015%+10mV)	
		Temperature Coefficient	±(0.15 × accuracy specification)/°C (0°-18°C & 28°-50°C)											
		Voltage Burden (4-wire mode)									1 00000			
	Current	Programmed Source Resolution &		Range ±1.0000μA		4 ±10	100.000µA ±1.000			±10.00000r	nA	±100.000mA	±1.00000A	
		Accuracy *1	Resolution				1nA 10			100nA	0.0	1μΑ	10µA	
		Townsontone Confficient	Accuracy ±(0.029%+300pA) ±(0.027%+700pA) ±(0.025%+6nA) ±(0.027%+60nA) ±(0.035%+600nA) ±(0.055%+6							±(0.055%+6μA)	±(0.22%+570µA)			
		Temperature Coefficient	±(0.1 × accuracy s	±(0.1 × accuracy specification) / °C (0°-18°C & 28°-50°C) <2.00000Ω 2.00000Ω 2.00000Ω 20.0000Ω 200.000Ω 2.00000Ω							20.0000kΩ			
			Resolution	~2.0000012		0μΩ	100μΩ		200.000Ω 1mΩ		2	10mΩ	100mΩ	
			Test current				100mA		10mA			1mA	100µA	
							±(0.1%+0.003Ω), Normal		±(0.08%+0.03Ω), Normal		±(0.07%+0.3Ω), Normal		±(0.06%+3Ω), Normal	
		P	Accuracy	Source IACC+Meas.	ACC Source IACC		:(0.07%+0.001Ω),						±(0.04%+1Ω), Enhanced	
		Range		200.000kΩ	2.00	000MΩ	20.0000M			000MΩ		00.000M Ω	x	
			Resolution	1Ω	1	0Ω	100Ω		1kΩ					
	Resistance		Test current	10µA		δμΑ	0.5µA			00nA				
			Accuracy	±(0.07%+30Ω), Normal ±(0.11%+300Ω), Normal ±(0.11%+1kΩ), Normal ±(0.66%+10kΩ), Normal Source IACC					ACC+Meas.VACC					
			,	±(0.05%+10Ω), Enha	±(0.05%+500Ω), E	nhanced	±(0.35%+5	kΩ), Enhanced	Jourcen	ice.meas.mee				
		Temperature Coefficient		specification)/°C (0°~1										
		Source I mode, Manual OHMS	Total uncertainty = I source accuracy + V measure accuracy (4-wire remote sense) Total uncertainty = V source accuracy + I measure accuracy (4-wire remote sense)											
		Source V mode, Manual OHMS												
		6-wire OHMS Mode		tive ohms guard and gu	aro sense. Max. Gua	ra Output Current	: 50mA (except 1A	range). Ac	curacy is load	aependent				
-	Maximum Range C	Guard Output Impedance	<0.1Ω in ohms m 75/second	bue										
			40ms (fixed source	a) vc										
	Maximum Measure Auto Range Time		NPLC / Trig	Mea:	lire	Sou	rce-Measure *9		Source-N	Aeasure Pass/Fai	il tost ::8 ::0	Mes	sure Memory *9	
	Sequence Reading	Speed	Origin	TO MEMORY	TO GPIB	TO MEMOR		PIR	TO MEM		O GPIB	TO MEMOR		
		Fast	0.01 / internal	2081 (2030)	1198 (1210)	1551 (1515)	1000 (9		902 (90		09 (840)	165 (162)	164 (162)	
SYSTEM SPEED *5	Rates *7	488.2	0.01 / external	1239 (1200)	1079 (1050)	1018 (990)	916 (8		830 (83		56 (780)	163 (162)	162 (160)	
	(rdg./second) for 60Hz (50Hz)	Medium	0.1 / internal	510 (433)	509 (433)	470 (405)	470 (4		389 (34		88 (343)	133 (126)	132 (126)	
		488.2	0.1 / external	438 (380)	438 (380)	409 (360)	409 (3		374 (33		74 (333)	131 (125)	131 (125)	
		Normal	1 / internal	59 (49)	59 (49)	58 (48)	58 (4		56 (47		56 (47)	44 (38)	44 (38)	
		488.2	1 / external	57 (48)	57 (48)	57 (48)	57 (4	7)	56 (47)	56 (47)	44 (38)	44 (38)	
	Single Reading	Speed	NPLC/ Trig		Measure					Measure *9		Source-Measure Pass/Fail t		
	Operation Rates (rdg./second) for 60Hz (50Hz)	•	Origin		TO GPIB	TO C					TO GPIB 79 (83)			
		Fast(488.2)	0.01 / internal		256 (256)		79 (83)							
		Medium(488.2)	0.1 / internal		167 (166) 49 (42)		72 (70)				69 (70)			
	. ,	Normal (488.2)	1 / internal			34 (31)				35 (30)				
	Component Interface Handler Time for 60Hz (50Hz) *8, *10	Speed	NPLC / Trig			Source Pass/Fail test TO GPIB				Source-Measure Pass/Fail test *9, *11 TO GPIB				
		Fast	Origin 0.01 / internal	1	TO GPIB 04 ms (1.08 ms)		0.5 ms (4.82 ms (5.3 ms)			
		Medium	0.01 / internal							6.27 ms (7.1 ms)				
		Normal	1 / internal	2.55 ms (2.9 ms) 17.53 ms (20.9 ms)			0.5 ms (0.5 ms) 0.5 ms (0.5 ms)			21.31 ms (25.0 ms)				
	Load Impedance		1/ metrial 1/.35 ms (20.9 ms) 21.31 ms (20.9 ms) 21.31 ms (20.9 ms) 21.31 ms (20.9 ms)											
	Differential Mode Voltage		Save and Sover and S											
	Common Mode Voltage		250VDC											
	Common Mode Isolation		>10GΩ, <1000pF											
SYSTEM	Over Range		105% of range, source and measure											
	Max. Voltage Drop		5V											
	Max. Sense lead Re		1ΜΩ											
	Sense Input Impedance		>100GΩ											
	Guard Offset Voltage		<150/W, typical Even of Constraint Amount List (mixed function). State Using and Len.											
	Source Output Modes Source Memory List		Fixed DC level, Memory List (mixed function), Stair (linear and log)											
			100 points max 5 000 points max											
GENERAL			5,000 readings @ 5 digits (two 2,500 point buffers). Includes selected measured value(s) and time stamp. Lithium battery backup(3 yr + battery life) IEEE-488.2 (SCPI), RS-232 ; 5 user-definable power-up states plus factory default and *RST.											
	Memory Buffer				IEEE-488.2 (SCPI), KS-232; Suser-definable power-up states pius factory default and -KS1. Active low input. Start of test, end of test, 3 category bits.; +SV@ 300mA supply.; 1 trigger input, 4 TTL/Relay Drive outputs (33V@500mA, diode)									
	Memory Buffer Programmability	or	IEEE-488.2 (SCPI)	, RS-232 ; 5 user-defina				4 TTL /Relaw	Drive output	ts (33V@500m∆	diode)			
	Memory Buffer Programmability Digital I/O Connect	or	IEEE-488.2 (SCPI) Active low input. 5	, RS-232 ; 5 user-defina Start of test, end of test,				4 TTL/Relay	Drive outpu	ts (33V@500mA	, diode)			
	Memory Buffer Programmability Digital I/O Connect Remote Interface	or	IEEE-488.2 (SCPI) Active low input. USB/GPIB/LAN/F	, RS-232 ; 5 user-defina Start of test, end of test, RS-232	3 category bits. ; +5\	/@ 300mA supply.	.; 1 trigger input, 4		Drive outpu	ts (33V@500mA	, diode)			
	Memory Buffer Programmability Digital I/O Connect Remote Interface Insulation		IEEE-488.2 (SCPI) Active low input. S USB/GPIB/LAN/R Chassis and term	, RS-232 ; 5 user-defina Start of test, end of test, RS-232 inal : 20MΩ or above (E	3 category bits. ; +5\ C 500V) ; Chassis an	/@ 300mÅ supply. Id AC cord : 30M Ω	. ; 1 trigger input, 4 2 or above (DC 500	DV)			, diode)			
	Memory Buffer Programmability Digital I/O Connect Remote Interface Insulation Operation Environr	nent	IEEE-488.2 (SCPI) Active low input. 3 USB/GPIB/LAN/F Chassis and term Indoor use, Altitu	, RS-232 ; 5 user-defina Start of test, end of test, RS-232 inal : 20M Ω or above (E de: \leq 2000m Ambient te	3 category bits. ; +5V C 500V) ; Chassis an mperature: 0 ~ 40°C	/@ 300mÅ supply. Id AC cord : 30M Ω	. ; 1 trigger input, 4 2 or above (DC 500	DV)			, diode)			
	Memory Buffer Programmability Digital I/O Connect Remote Interface Insulation Operation Environme Storage Environme	nent	IEEE-488.2 (SCPI) Active low input. 3 USB/GPIB/LAN/F Chassis and term Indoor use, Altitu	, RS-232; 5 user-defina Start of test, end of test, RS-232 inal : 20MΩ or above (E de: ≤ 2000m Ambient te C ~ 70°C; Humidity: < 8	3 category bits. ; +5V C 500V) ; Chassis an mperature: 0 ~ 40°C	/@ 300mÅ supply. Id AC cord : 30M Ω	. ; 1 trigger input, 4 2 or above (DC 500	DV)			, diode)			
	Memory Buffer Programmability Digital I/O Connect Remote Interface Insulation Operation Environr	nent nt	IEEE-488.2 (SCPI) Active low input. USB/GPIB/LAN/F Chassis and term Indoor use, Altitu- Temperature: -20	, RS-232; 5 user-defina Start of test, end of test, RS-232 inal : 20MΩ or above (E de: ≤ 2000m Ambient te C ~ 70°C; Humidity: < 8	3 category bits. ; +5V C 500V) ; Chassis an mperature: 0 ~ 40°C	/@ 300mÅ supply. Id AC cord : 30M Ω	. ; 1 trigger input, 4 2 or above (DC 500	DV)			, diode)			

NOTE: 1. Speed = Normal (1 NPLC). For 0.1 PLC, add 0.005% of range to offset specifications, except 200mV, 1A ranges, add 0.05%. For 0.01 PLC, add

0.05% of range to offset specifications, except 200mV, 1A ranges, add 0.5%.

2. Required to reach 0.1% of final value after Command is processed. Resistive load. $10\mu A$ to 100mA range.

3. Overshoot into a fully resistive 100 k Ω load, 10Hz to 1MHz BW, adjacent ranges: 100mV typical, except 20V/200V.

Maximum time required for the output to begin to change following the receipt of : SOURce : VOLTage|CURRent <nrf> Command.
 Reading rates applicable for voltage or current measurements, autorange off, filter off, display off, trigger delay = 0, and binary reading forma.
 Purely resistive lead. 1µA and 10µA ranges <65ms.

ACCESSORIES

7. 1000 point sweep was characterized with the source on a fixed rang.

8. Pass/Fail test performed using one high limit and one low math limit.

Includes time to re-program source to a new level before making measurement.
 Time from falling edge of START OF TEST signal to falling edge of END OF TEST signal.
 Command processing time of : SOURce : VOLTage|CURRent : TRIGgered <nrf> Command not included.

ORDERING INFORMATION

RSSM-20H10 with GPIB	Source Measure Unit
RSSM-20H10	Source Measure Unit

Quick Start manual x 1, Test Lead GTL-207A x 1, Alligator Clip x 2 **OPTIONAL ACCESSORIES**

 SM-01
 Digital I/O Adapter, Convert DB15 to DB9 + 8-pin micro-DIN
 GTL-258
 GPIB Cable (25 pin

 SM-02
 Digital I/O Adapter, Convert DB15 to DB37 + 8-pin micro-DIN
 Micro-D Connector)
 Micro-D Connector)
 Micro-D Connector) GTL-246 USB Cable (USB 2.0 A-B Type, approx.. 1200mm)

Specifications subject to change without notice.



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